

4 / CFR 4
E. Uilleb
4-24-02

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Shin FUJITA

Application No.: 09/994,675

Docket No.: 110954

Filed: November 28, 2001

For: TEST METHOD OF ELECTRO-OPTICAL DEVICE, TEST CIRCUIT OF
ELECTRO-OPTICAL DEVICE, ELECTRO-OPTICAL DEVICE, AND
ELECTRONIC EQUIPMENT

REQUEST FOR CORRECTION OF PALM RECORDS

Director of the U.S. Patent and Trademark Office
Washington, D.C. 20231

Sir:

Attached is a photocopy of the original filing receipt on which errors have been corrected in red. These errors are being brought to the attention of the Patent and Trademark Office so that it may correct its records.

Respectfully submitted,

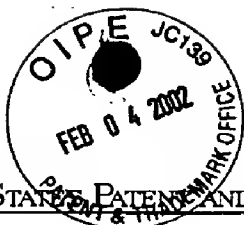
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Date: February 4, 2002

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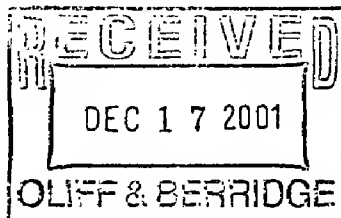


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APPLICATION NUMBER	FILING DATE	GRP ART UNIT	FIL FEE REC'D	ATTY. DOCKET NO	DRAWINGS	TOT CLAIMS	IND CLAIMS
09/994,675	11/28/2001	2877	908	110954	10	16	5

25944
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CONFIRMATION NO. 8457
FILING RECEIPT



OC000000007186961

Date Mailed: 12/12/2001

Receipt is acknowledged of this nonprovisional Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Customer Service Center. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

Applicant(s)

Shin Fujita, Suwa-shi, JAPAN;

Assignment For Published Patent Application

SEIKO EPSON CORPORATION, Tokyo, JAPAN;

Domestic Priority data as claimed by applicant

Foreign Applications

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If Required, Foreign Filing License Granted 12/12/2001

Projected Publication Date: To Be Determined - pending completion of Missing Parts

Non-Publication Request: No

Early Publication Request: No



Title

Test method of electro-optical device, test circuit of *electro* electro-optical device, electro-optical device, and electronic equipment

Preliminary Class